

<b>Notice of References Cited</b>	Application/Control No. <b>09/980,112</b>	Applicant(s)/Patent Under Reexam <b>Ohsawa et al.</b>	
	Examiner <b>Stephen Funk</b>	Art Unit <b>2854</b>	Page 1 of 1

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B	6,412,916	7/2002	Okano et al.	347	55
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	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
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<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.